Se	earch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/027,991	CHEN ET AL.
Examiner	Art Unit
Hetul Patel	2186

r ³	SEARCHED			
Class	Subclass	Date	Examiner	
711	170-173	4/25/2005	НВР	
709	212-219	4/25/2005	НВР	
	231-232	4/25/2005	НВР	
718	104	4/25/2005	НВР	
707	205	4/25/2005	НВР	

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH (INCLUDING SEA	NOTI	ES STRATEGY)
		DATE	EXMR
EAST		4/25/2005	НВР
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